

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination INABA ET AL.	
		Examiner Jacques Veillard	Art Unit 2165	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,883,001	04-2005	Abe, Seiichiro	707/10
*	B	US-6,701,318	03-2004	Fox et al.	707/10
*	C	US-6,473,754	10-2002	Matsubayashi et al.	707/5
*	D	US-7,035,861	04-2006	Kayahara, Naoki	707/100
*	E	US-7,120,625	10-2006	Kagimasa et al.	707/3
*	E	US-7,089,227	08-2006	Abe et al.	707/3
*	G	US-6,499,030	12-2002	Igata, Nobuyuki	707/6
*	H	US-6,549,898	04-2003	Inaba et al.	707/5
*	I	US-6,665,667	12-2003	Inaba et al.	707/5
*	J	US-5,774,888	06-1998	Light, John	707/1
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.